



<b>Search Notes</b>  	Application/Control No.  10820314	Applicant(s)/Patent Under Reexamination  EMA, HIDEYUKI
	Examiner Chang, Rick K	Art Unit 3729

Notes	Date	Examiner
east search	10/20/06	rc
U.S. Patent and Trademark Office		Part of Paper No.: 20061020

<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10820314</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>EMA, HIDEYUKI</p>
	<p>Examiner</p> <p>Chang, Rick K</p>	<p>Art Unit</p> <p>3729</p>

Class	SubClass	Date	Examiner
29	33 F, 33 M, 745,747,748,749,751,753,755,757, 759,761,711,715	10/20/06	rc
83	282,439,452		

U.S. Patent and Trademark Office	Part of Paper No.: 20061020
----------------------------------	-----------------------------